Multiple time scale blinking in InAs quantum dot single-photon sources

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We use photon correlation measurements to study blinking in single, epitaxially-grown self-assembled InAs quantum dots situated in circular Bragg grating and microdisk cavities. The normalized second-order correlation function $g^{(2)}(\tau)$ is studied across eleven orders of magnitude in time, and shows signatures of blinking over timescales ranging from tens of nanoseconds to tens of milliseconds. The $g^{(2)}(\tau)$ data is fit to a multi-level system rate equation model that includes multiple non-radiating (dark) states, from which radiative quantum yields significantly less than 1 are obtained. This behavior is observed even in situations for which a direct histogramming analysis of the emission time-trace data produces inconclusive results.

Single-photon sources based on single epitaxially-grown quantum dots (QDs) are promising devices for photonic quantum information science [1, 2]. As single-photon source brightness is crucial in many applications, III-V compound nanostructures like InAs QDs in GaAs are of particular interest, both due to their short radiative lifetimes (typically $\approx 1 \text{ ns}[3]$) and the availability of mature device fabrication technology for creating scalable nanophotonic structures which can modify the QD radiative properties in desirable ways. In particular, structures can be created to further increase the QD radiative rate [4] and funnel a large fraction of the emitted photons into a desired collection channel [5].

The overall brightness of the source is, however, also influenced by the radiative efficiency of the QD, which can deviate from unity for a variety of reasons, including coupling of the radiative transition to nonfluorescing states. Such fluorescence intermittency, also called blinking, is an apparently ubiquitous phenomenon in solid-state quantum emitters [6, 7, 9, 19], being particularly pronounced in single nanocrystal QDs and organic molecules. In contrast, blinking in epitaxially-grown III-V QDs has not received as much attention, largely due to the fact that such QDs, grown in ultra-high-vacuum environments and embedded tens of nanometers below exposed surfaces, typically do not express pronounced fluorescence intermittency [10, 11]. Obvious blinking (at the ≈ 100 ms to ≈ 1 s time scales) has only been observed in InGaAs QDs grown close to crystal defects[22] and in some InP QDs[17, 21]. Sub-microsecond blinking dynamics in InAs QDs have also been studied[15].

Here, we study blinking in InAs/GaAs QDs embedded in photonic nanostructures that enable high collection efficiencies ($\approx 10~\%$)[2, 3]. As these devices do not exhibit pronounced fluorescence variations, we use photon correlation measurements[18] as a more informative approach to investigate blinking over time scales ranging from tens of nanoseconds to hundreds of milliseconds. The data is

fit with a multi-level rate equation model for the QD that yields estimates for the transition rates and occupancies of the QD states, enabling an overall estimate of the QD radiative efficiency. Notably, we find quantum yields significantly less than 1 even in QDs which show no blinking in histogramming analysis. This information is valuable in quantifying the extraction efficiency of QD emission, and in understanding the ultimate brightness achievable for QD single-photon sources. We anticipate that the importance of this topic is likely to grow as epitaxially-grown QDs are incorporated within photonic nanostructures with critical dimensions of tens of nanometers, at which point surfaces play an important role[19].

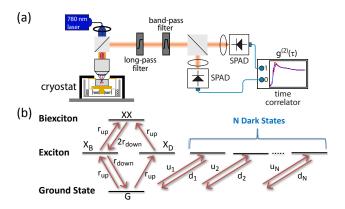


FIG. 1. (a) Experimental setup (b) Multi-level model with N dark states used to describe the QD behavior. Pumping into the "bright" and "dark" single excitonic states (X_B and X_D) from the ground state (G), and the biexciton state (XX) from the single exciton states, occurs at a rate $r_{\rm up}$. Spontaneous emission from the biexciton (exciton) state occurs at a rate $2r_{\rm down}$ ($r_{\rm down}$). The up-transition (down-transition) rates between the ground state and dark states are labeled u_i (d_i), where $i{=}1..N$.

Our samples consist of InAs QDs embedded in the center of a 190 nm thick GaAs layer. The collection efficiency of emitted photons is enhanced through the use

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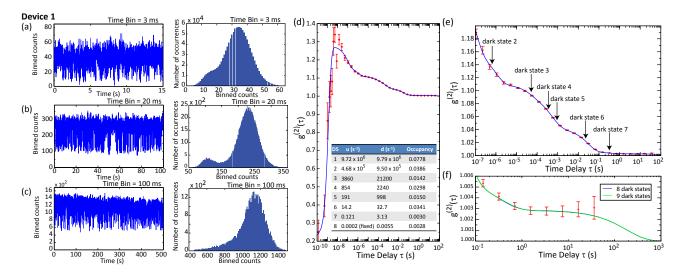


FIG. 2. Device 1 data. Time-trace (left) and histogram data (right) for (a) 3 ms, (b) 20 ms, and (c) 100 ms time bins. (d) $g^{(2)}(\tau)$; red points: experimental data; blue solid line: nonlinear least-squares fit to the N dark state model in Fig. 1(b), with N=8. Inset table: fit values for excitation (u) and decay (d) rates and occupancy of each dark state (DS). (e) Same as (d), but zoomed-in to the region between $\tau=100$ ns and $\tau=100$ s. Times $\tau_i=1/(u_i+d_i)$ are used as labels for the dark states, approximately indicating the locations of maximal slope in a plot of $g^{(2)}(\tau)$ vs. $\log(\tau)$. (f) Comparison of model for N=8 and N=9, in the region between $\tau=10$ ms and $\tau=1000$ s. Within the region for which experimental data is available, no significant difference is seen for N>8. The estimated QD radiative efficiency is 78 %.

of a circular grating microcavity[2, 3] or fiber-coupled microdisk cavity geometry[5], as detailed in the Supplementary Material[21]. The devices are cooled to 10 K in a liquid helium flow cryostat and excited by a 780 nm (above the GaAs bandgap) continuous wave laser. The collected emission is spectrally filtered (bandwidth $< 0.2 \text{ nm} \approx 250 \mu\text{eV}$) to select a single state of a single QD (typically the bi-exciton or neutral exciton state), split on a 50/50 beamsplitter, and sent to a pair of silicon single-photon counting avalanche diodes (SPADs) (see Fig. 1(a)). The SPAD outputs are directed to a time-correlator that records photon arrival times for each channel with a resolution of 4 ps. Data is typically recorded over a period of 1 h. Results from three different devices (labeled 1,2,3) are described below.

Figure 2(a) shows a portion of the fluorescence time trace recorded from device 1, where detection events are binned into 3 ms bins. The time trace data clearly shows a fluctuating fluorescence intensity, more often exhibiting high than low levels. This is further seen in the histogram of detection events per bin shown next to the time trace, which exhibits a bimodal behavior biased towards the higher count rates. Figures 2(b) and 2(c) show the corresponding time trace and histogram data for 20 ms and 100 ms time bins. At the 20 ms bin width, a bimodal distribution in the histogram is more clearly seen. At 100 ms, it becomes less visible, as is the contrast between high and low intensities in the time trace. When the bin width is increased to 1000 ms, obvious signs of blinking are no longer observable in either the time trace or histogram data[21].

The sensitivity of time trace and histogram data to the choice of bin width is well-known[18, 20, 22], and can limit the ability to achieve a complete picture of the system dynamics. In particular, the minimum reliable bin size is limited by the available photon flux and the shot noise, while too large bin sizes average out fluctuations occurring at shorter time scales. Histogram analvsis of the high or low fluorescence level time interval distributions is furthermore influenced by the selection of a threshold intensity level. In contrast, intensity autocorrelation analysis does not require such potentially arbitrary input parameters. In Fig. 2(d), we plot the intensity autocorrelation function $q^{(2)}(\tau)$ for device 1 over a time range exceeding eleven orders of magnitude (error bars are due to fluctuations in the detected photon count rates, and represent one standard deviation[21]). This data, calculated using an efficient approach[21] similar to that described in ref. 7, indicates that the photon antibunching at $\tau=0$, expected for a single-photon emitter, is followed by photon bunching that peaks in the 10 ns region before slowly decaying, with $g^{(2)}(\tau) = 1$ only occurring for $\tau > 0.1$ s (see zoomed-in data in Fig. 2(e)). The decay in $g^{(2)}(\tau)$ is punctuated by a series of inflection points ('shoulders') in which the concavity of the curve changes. Such features have been observed in fluorescence autocorrelation curves of single aromatic molecules in polymeric hosts[23, 25]. Photon bunching in these systems arises from shelving of the molecule into dark triplet states, resulting in bursts of emitted photons followed by dark intervals at characteristic rates. Similar behavior can also originate from interactions between the molecule and neighboring two-level systems (TLS) in the host polymer. Switching between the states of the TLS leads to sudden jumps in emission frequency, and correspondingly, emission intensity. Multiple shoulders in the autocorrelation have been associated with coupling to a number of TLSs with varying switching rates.

We interpret our $g^{(2)}(\tau)$ data similarly, taking the radiative QD transition to be coupled to multiple nonradiative, or dark, states[21], as depicted in Fig. 1(b). This phenomenological model is motivated by potential physical mechanisms present in self-assembled InAs/GaAs QDs. For example, lattice defects in the vicinity of the QD can act as carrier traps, and charge tunneling events between the QD and such traps lead to fluorescence intermittency[21, 22]. Perturbation of the electron and hole wavefunction overlap by the local electric field of trapped charges has also been postulated as a cause of blinking[17]. Another possibility is that tunneling of carriers into nearby traps causes spectral shifts of the QD emission out of the ≈ 0.2 nm filter bandwidth, leading to an effective blinking behavior. Such shifts would however be larger than the spectral diffusion measurements recently reported [15, 16, 27, 29]. We did not observe such spectral diffusion in spectroscopy with a 0.035 nm resolution.

In these scenarios, interactions with surrounding traps drive the QD into high or low emission states with well-defined rates, consistent with the model of Fig. 1(b). Here, each dark state i is populated at a rate u_i and de-populated at a rate d_i . We solve the rate equations to compute $g^{(2)}(\tau)$ using the appropriate transition for each device: The XX \rightarrow X_B transition for devices 1 and 2, and the X_B \rightarrow G transition for device 3. All parameters are varied in the fit except for the radiative decay rate, r_{down} , which is determined from independent measurements[21]. A first estimate of the number of dark states used in the model is the number of shoulders in the measured $g^{(2)}(\tau)$ data. Ultimately, the number of dark states is determined by the χ^2 parameter minimized in the fit, as defined in[21].

Fits to device 1 data are shown as blue solid lines in Figs. 2(d)-(e), along with extracted occupancy and population and de-population rates, u_i and d_i , of each dark state. The short (< 10 ns) time behavior of $g^{(2)}(\tau)$ depends primarily on the excitation rate $r_{\rm up}$, the decay rate r_{down} , the SPAD timing jitter, and the background signal, if present[21]. The behavior at longer times depends primarily on u_i and d_i . Accurate fits require a minimum number N of dark states (8 for this device), below which the behavior of $g^{(2)}(\tau)$, quantified by the fit χ^2 , is not well reproduced. Larger N has negligible impact on the fit (Fig. 2(f)), and the total dark state occupancy changes by < 0.05 %. The radiative quantum yield (radiative efficiency) is estimated by subtracting this total dark state occupancy from unity. We note that as the rates coupling states G, X_B, X_D, and XX are more than an order of magnitude faster than rates to the dark states, the quality of the fits and the resulting quantum yield does not depend on whether the dark states are coupled to G (Fig. 1) or X_B . Similarly, replacing the dark states with partially emissive gray states[11], modeled with a branching ratio between dark and bright transitions, does not significantly affect the fits or computed quantum yield[21].

In all, the $q^{(2)}(\tau)$ data and rate equation analysis uncover qualitatively new information about blinking in this device in comparison to the time trace and histogram data. First, we see that blinking occurs across a wide variety of time scales. While blinking at submicrosecond time scales has been reported in epitaxially grown InAs QDs previously[15, 32], our measurements show that these systems can exhibit blinking out to hundreds of milliseconds. One physical picture qualitatively consistent with this observation would be that blinking is caused by the tunneling of carriers between the QD and several adjacent traps of varying separation from the QD. For example, Sercel and colleagues have considered electron relaxation from a QD through a deep level trap [14, 33], and calculated that tunneling rates can vary by several orders of magnitude over a few tens of nanometers of QD-trap separation (see Supplementary Material for a plot of these tunneling rates). Such deep level traps may arise during the QD growth process itself [12, 13, 33] may physically correspond to impurities, such as vacancies, antisites, and interstitials, produced during growth and post-growth fabrication processes. We point out that a rapid thermal annealing step was used to blue-shift the QD emission in our wafers [4, 21], prior to device fabrication.

The estimated total dark state occupancy is 21.6 %, so the radiative transition is still dominantly preferred over excitation into the dark states, with a radiative quantum yield of 78.4 %. Finally, we note that the rates u_i and d_i for populating/de-populating dark state i can at least be qualitatively linked to the location of prominent features in the $q^{(2)}(\tau)$ data. For example, in a system consisting of a single dark state that is populated and de-populated at rates u_1 and d_1 , the slope of $g^{(2)}(\tau)$ plotted vs. $\log(\tau)$ is maximimal at $\tau = 1/(u_1 + d_1)[18]$. In a system comprised of multiple dark states, if excitation and decay rates are sufficiently different, the values $\tau_i = 1/(u_i + d_i)$ still approximately point to slope maxima. Figure 2(e) identifies these points, which qualitatively match the experimentally observed maximum slope points. Quantitative details are given in [21].

Repeating this analysis for device 2 yields the results in Fig. 3. Here, neither time trace nor histogram data show clear evidence of blinking. In contrast, $g^{(2)}(\tau)$ in Fig. 3(c) again evidences bunching at the ten nanosecond time scale, followed by a series of shoulders, before reaching a value of unity. The data is fit to a rate equation model with five dark states, and again shows close correspondence (inset to Fig. 3(c)). Contrasting with device

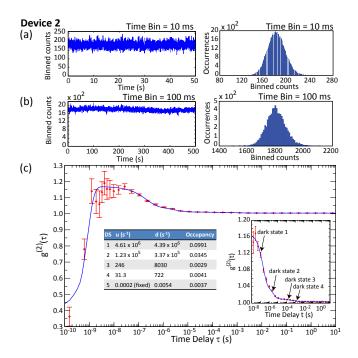


FIG. 3. Device 2 data. Time-trace (left) and histogram data (right) for (a) 10 ms and (b) 100 ms time bins. (c) $g^{(2)}(\tau)$; red points: experimental data; blue solid line: nonlinear least-squares fit to the model with $N{=}5$. Inset table: fit values for excitation (u) and decay (d) rates, and occupancy of each dark state (DS). Inset graph: data over $\tau{=}[10 \text{ ns}, 10 \text{ s}]$. Points $\tau_i = 1/(u_i + d_i)$ are indicated for each dark state. The estimated QD radiative efficiency is 86 %.

1, blinking at longer times (e.g., $> 10~\mu s$) is significantly less pronounced, and the estimated total dark state occupancy is 14.4 %.

Finally, we present data from device 3 in Fig. 4. Similar to device 2, the time trace and histogram data show little evidence of blinking. The $g^{(2)}(\tau)$ data does reveal significant blinking over sub-microsecond time scales, but at longer times blinking is minimal and the system can be well fit to a model with N=3 (with final state occupancy < 0.5 %). Interestingly, the total dark state occupancy is 46.7 %, significantly greater than observed in either device 1 or 2. Thus, despite qualitative similarity with the time trace and histogram data of device 2, the dynamics of the QD are in fact qualitatively different, as revealed by the photon correlation measurements. This qualitative difference is perhaps unsurprising given its entirely different device history (different wafer growth; no rapid thermal annealing [21]. Also, as the pronounced bunching persists out to μ s time scales, an accurate estimate of $g^{(2)}(0)$, needed for assessing the purity of the singlephoton source, requires acquisition and analysis of data out to many orders of magnitude longer times than the characteristic time scale of the antibunching dip.

Correlation functions can reveal the kinetics of the blinking signal over a large time range, however only in

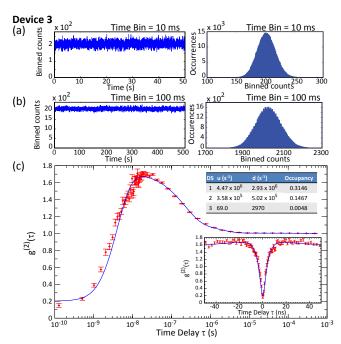


FIG. 4. Device 3 data. Time-trace (left) and histogram data (right) for (a) 10 ms and (b) 100 ms time bins. (c) $g^{(2)}(\tau)$; red points: experimental data; blue solid line: nonlinear least-squares fit to the model with $N{=}3$. Inset table: fit values for excitation (u) and decay (d) rates and occupancy of each dark state (DS). Inset plot: data with linear time scale showing the anti-bunching dip at $\tau=0$; the pronounced photon bunching away from zero delay is not evident on this scale. The estimated QD radiative efficiency is 53 %.

a time-averaged sense[18]. Information about instantaneous intensity fluctuations, such as probability distributions for bright and dark intervals, can be obtained from photon-counting histograms, as commonly done in the blinking literature[18–20]. Applied to epitaxially-grown QDs, this type of analysis has revealed exponential blinking time distributions[17, 21, 22], suggesting modification of the QD fluorescence by one or a few neighboring centers, as discussed (nanocrystal QDs have in contrast been shown to display power-law distributions[20]). We have applied this technique to the QD in Device 1. Although our measured data does not strictly follow the stringent criteria suggested in[20] for reliable parameter extraction, we see strong indications of exponential probability distributions[21].

In summary, photon correlation measurements taken over eleven orders of magnitude in time are used to study blinking in epitaxially-grown, self-assembled InAs QDs housed in photonic nanocavities. The measurements are fitted to a rate equation model consisting of a radiative transition coupled to a number of dark states. The model reproduces the observed behavior, allowing us to quantify the multiple blinking time scales present and estimate the QD radiative efficiency, which ranges between 53 % and

85~%. We anticipate that this approach will be valuable in studying the behavior of InAs QDs in proximity (< $100~\rm nm$) to etched surfaces and/or metals in nanophotonic/nanoplasmonic geometries. Indeed, the blinking observed here may stem from traps produced in the fabrication of the nanostructures used to enhance QD emission collection. Measuring photon correlations across this broad range of time scales both before and after nanofabrication may help elucidate the origin of blinking in these systems.

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SUPPLEMENTAL INFORMATION

DEVICE DETAILS

Devices based on two different quantum dot (QD) wafers are studied in this work. Devices 1 and 2 come from wafer A, which is made of an epistructure consisting of a 190 nm thick GaAs waveguide layer on top of a 1 μ m thick, Al_{0.6}Ga_{0.4}As sacrificial layer. The as-grown emission wavelength of the QD s-shell is near 1100 nm, so the samples are blue-shifted to a wavelength near 940 nm using a rapid thermal annealing process [1] performed at 830°C, so that the QD emission can be detected using efficient Si single-photon avalanche diodes (SPADs). Circular grating microcavities [2, 3] are fabricated in order to increase the fraction of QD emission collected by the 0.42 numerical aperture (NA) lens used in the confocal microscope setup.

Device 3 comes from wafer B, which is made of a similar epistructure as wafer A, but has an as-grown QD sshell emission wavelength near 980 nm, so that no rapid thermal annealing process is performed on this wafer (in comparison to Devices 1 and 2, we note that the lack of a rapid thermal annealing step may have a significant effect on the behavior of deep level traps in the material [4]). Microdisk cavities are fabricated to increase the collection efficiency of emitted photons, with a fiber taper waveguide interface used to extract photons from the microdisk optical mode [5]. Scanning electron microscope images of the fabricated devices are shown in Fig. S1. Figure S2 shows the fluorescence spectrum of each device, under the non-resonant 780 nm cw excitation conditions used in the photon counting measurements presented in the main text.

Devices 1 and 2 were previously studied under pulsed (80 MHz rep rate), 820 nm non-resonant excitation in Ref. [3], where the performance of the devices as triggered single-photon sources was assessed. There, a photon collection efficiency of 9.5~% and 5.6~% into the NA=0.42lens was estimated for the two devices, respectively, under the assumption of unity radiative quantum yield. As the radiative quantum yields we estimate in the main text of the current work are less than unity (78 % and 86 %), this indicates that the collection efficiencies determined in the prior work were likely underestimated (by approximately 28 % and 16 %, respectively). This correction is tentatively presented, however, both because the data for the two works were acquired on different occasions, and more importantly, because the excitation conditions differ (different wavelength and pulsed vs. cw pumping). Finally, we note that while Device 3 comes from the same chip as the fiber-coupled microdisk single-photon source studied in Ref. [5], it is not precisely the same device, and had an estimated collection efficiency that was about an order of magnitude lower (on the order of 1 % into one

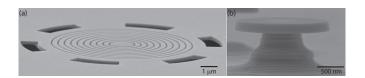


FIG. S1. Scanning electron microscope images of the (a) circular grating microcavity and (b) microdisk cavity geomtry used in this work to efficiently extract photons from a single quantum dot.

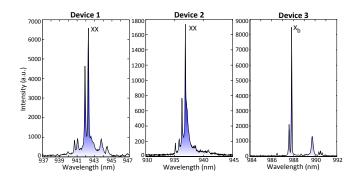


FIG. S2. Photoluminescence spectra for Devices 1, 2, and 3, under 780 nm cw excitation near saturation. The specific QD transition that is spectrally selected for photon counting measurements (XX for Devices 1 and 2, X_b for Device 3) is indicated in each spectrum.

channel of the optical fiber).

EXPERIMENTAL DETAILS

The devices were cooled to 10 K in a liquid helium flow cryostat and excited, non-resonantly, by a 780 nm (above the GaAs bandgap) continuous wave laser. Devices 1 and 2 were excited with a free-space beam though a NA 0.42 objective. Photoluminescence (PL) emitted by QDs contained in the circular grating microcavities was collected through the same objective and focused into a singlemode optical fiber, to be routed towards detection [3]. Quantum dots in Device 3 were optically excited with a fiber taper waveguide (FTW) evanescently coupled to the hosting microdisk, and the emitted PL was collected with the same optical fiber [5]. In both situations, the collected PL was spectrally filtered to select only a single state of a single QD (the bi-exciton or neutral exciton state - see Fig. S2). For devices 1 and 2, a monochromator was used as a filter, with a bandwidth of ≈ 100 pm. In the case of Device 3, two cascaded holographic gratings were used, providing an overall bandwidth of ≈ 200 pm. The filtered PL was split on a 50/50 beamsplitter and sent to a pair of silicon single-photon counting avalanche diodes (SPADs). The SPAD outputs were directed to a time-correlator that recorded photon arrival times for each channel with a resolution of 4 ps. The SPAD timing

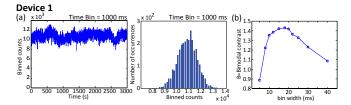


FIG. S3. Device 1 supplemental data. (a) Time-trace (left) and histogram data (right) for 1000 ms time bins, (b) Bimodal contrast parameter as a function of time bin width.

jitter was ≈ 500 ps.

HISTOGRAM DATA

The measured data consisted of a series of time tags corresponding to single-photon detection events. To produce the time-domain blinking trajectories shown in the main text, detection events in the raw time-tag data were placed into a sequence of bins of duration Δt . Histograms for number of detection events per bin were generated from the blinking trajectories. The number of histogram bins was selected through the Freedman-Diaconis method [6].

In Fig. 2 in the main text, we show time trajectory and histogram data for Device 1 using time bin widths of 3 ms, 20 ms, and 100 ms. This represents essentially the full range of bin widths over which appreciable blinking can be directly observed in trajectory and histogram data. For example, a bin width of 1000 ms shows little variation in the collected emission intensity in the time trajectory, and the histogram data does not show evidence of a bimodal distribution (Fig. S3(a)).

For time bin widths over which a bimodal distribution is visible, we define a contrast parameter $B=|1-I_{\min}/I_1|+|1-I_{\min}/I_2|$, where I_1 and I_2 are the intensities of the two maxima and I_{\min} is the minimum intensity between the two peaks. In Fig. S3(b), we plot B as a function of time bin width for Device 1. We see that there is a relatively small range of time bin widths over which a bimodal distribution is evident, with the contrast optimized at ≈ 20 ms, for which data was plotted in the main text in Fig. 2(b).

CALCULATION OF $g^{(2)}(\tau)$ FROM TIME-TAGGED DATA

The experimental setup yields two streams of data corresponding to photon arrival events on SPADs 1 and 2, collected over a period of 1 h. These two data streams were used to calculate the second-order correlation func-

tion

$$g^{(2)}(\tau) = \frac{\langle I_1(t)I_2(t+\tau)\rangle}{\langle I_1(t)\rangle\langle I_2(t)\rangle},\tag{S1}$$

where $I_1(t)$ and $I_2(t)$ are the photon fluxes in SPADs 1 and 2. To calculate $g^{(2)}(\tau)$, we use an efficient approach similar to that in Ref. 7. We initially specify M non-overlapping time windows $[\tau_1^{\min}, \tau_1^{\max}), [\tau_2^{\min}, \tau_2^{\max}), \dots [\tau_M^{\min}, \tau_M^{\max}),$ with $\tau_{i+1}^{\min} = \tau_i^{\max}$, which are used to bin detection events in the SPAD 1 stream. The arrival times of all the photons in each of the M time windows is initially stored. When the time t is shifted to the next arrival time in the SPAD 2 stream, photon numbers in all time windows in the SPAD 1 stream are updated, shifting on average 1 photon from window i to window i+1. Thus the overall computation scales as O(NM) for N photons and M time windows instead of the $O(N^2)$ cost of a direct computation of $g^{(2)}(\tau)$.

To determine the uncertainty of the calculated $g^{(2)}(\tau)$ due to signal fluctuations caused by varying experimental conditions, the original data is divided into n > M bins, to which the procedure above is applied. The covariance matrix

$$C_{ij} = \frac{1}{n-1} \left(\frac{1}{n} \sum_{k=1}^{n} (g_k^{(i)} - \bar{g}^{(i)}) (g_k^{(j)} - \bar{g}^{(j)}) \right)$$
(S2)

is then calculated, where $g_k^{(i)}$ is the measured value of the ith time window of $g^{(2)}$ in the kth statistical bin, and $\bar{g}^{(i)}$ is the mean $g^{(2)}$ over the n statistical bins (we drop the (2) superscript in $g^{(2)}$ for clarity). The error bars shown in the plots in the main text are the standard deviations of the individual observations: $\sigma_i = \sqrt{C_{ii}}$.

RATE EQUATION MODEL AND FITS

The dynamics of the quantum dots are modeled by the transitions shown schematically in Fig. 1b of the main text. The states are defined as:

G Ground state

 X_B Bright exciton

X_D Dark exciton

XX Bi-exciton

i The i-th dark state

The populations p evolve according to the rate equations:

$$\frac{dp_{XX}}{d\tau} = r_{up}(p_{X_B} + p_{X_D}) - 2r_{down}p_{XX}$$

$$\frac{dp_{X_B}}{d\tau} = 2r_{down}p_{XX} + r_{up}p_G - (r_{up} + r_{down})p_{X_B}$$

$$\frac{dp_{X_D}}{d\tau} = r_{up}p_G - r_{up}p_{X_D}$$

$$\frac{dp_G}{d\tau} = r_{down}p_{X_B} + \sum_i d_i p_i - (2r_{up} + \sum_i u_i)p_{X_G}$$
(S3)

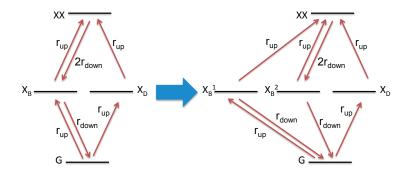


FIG. S4. States and transitions for the computation of $g^{(2)}(\tau)$ for the XX \to X_B transition. The state X_B is split into two states: X¹_B and X²_B. With initial conditions of $p_{X^1_B}(\tau=0)=1$, the correlation function is simply given by $g^{(2)}(\tau)=p_{X^2_B}(\tau)$. Dark states are not shown in these diagrams for clarity.

$$\frac{dp_i}{d\tau} = u_i p_{X_G} - d_i p_i$$

where u_i and d_i are the up-transition and down-transition rates between the ground state G and the *i*th dark state. The state X_D in the model corresponds to an electronhole pair with parallel spins. This state, normally called the dark exciton, is approximately degenerate with the bright exciton state X_B , however is not optically active. The additional N dark states can either be non-emissive or may emit outside the filtered detection window, as detailed in the experimental setup description.

By monitoring the power dependence of the luminescence, we determined that the $XX \to X_B$ transition was being measured in Devices 1 and 2, while the $X_B \to G$ transition was measured in Device 3. For Devices 1 and 2, the correlation function $g^{(2)}(\tau)$ is the probability that two photons from the $XX \to X_B$ transition are emitted a time interval τ apart. To compute $g^{(2)}(\tau)$, we integrate the rate equations (S3) setting the initial conditions to be $p_{X_B}(\tau=0)=1$ with all other populations zero; $g^{(2)}(\tau)$ corresponds to the probability that the system will return to state X_B through the $XX \to X_B$ transition [8]. To compute this probability, we split the state X_{B} into two states in the rate equations as shown in Fig. S4. $X_{\rm B}^2$ can only be reached via the $XX \rightarrow X_B$ transition. All other transitions to state X_B are directed to X_B^1 . All transitions away from state $X_{\rm B}$ are included for both $X_{\rm R}^1$ and X_B^2 . Initially we set $p_{X_B^1}(\tau=0)=1$ with all other populations zero. Then $g^{(2)}(\tau) = p_{X_p^2}(\tau)$.

For Device 3, $g^{(2)}(\tau)$ is the probability that two photons from the $X_B \to G$ transition are emitted a time interval τ apart. Similarly to the case above, we split state G into two states: G^2 which can only be reached via the $X_B \to G^2$ transition, and G^1 , which is reached by all other transitions to G, namely the recoveries from the dark states in Fig. 1(b). Setting $p_{G^1}(\tau = 0) = 1$ with all other populations zero, $g^{(2)}(\tau) = p_{G^2}(\tau)$.

We find the short-time behavior of $g^{(2)}(\tau)$ can be used to determine the ratio $r_{\rm up}/r_{\rm down}$ but not the individual

TABLE I. Additional parameters for the three devices not included in the main text.

Device	$r_{\rm up}(s^{-1})$	$r_{\text{down}}(s^{-1})$
1	1.11×10^{9}	0.60×10^{9}
2	2.11×10^{9}	1.25×10^9
3	0.16×10^{9}	0.75×10^{9}

values of $r_{\rm up}$ and $r_{\rm down}$. We therefore determine the values of $r_{\rm down}$ using independent decay-rate measurements. The values of $r_{\rm up}$ and $r_{\rm down}$ for the three devices are given in Table I.

The remaining parameters were determined by a χ^2 fit of $g^{(2)}(\tau)$ computed from the rate equations. For uncorrelated output, the covariance matrix C is diagonal. With correlations, χ^2 is defined as:

$$\chi^2 = \sum_{ij} (\bar{g}^{(i)} - g_{\text{fit}}^{(i)}) C_{ij}^{-1} (\bar{g}^{(j)} - g_{\text{fit}}^{(j)}), \quad (S4)$$

where $g_{\text{fit}}^{(i)}$ is the fitting function determined by solving the rate equations (S3) [9].

The fits found a background signal of 9 % for Device 3; zero background was found for Devices 1 and 2 [10]. A timing jitter of $\sigma = 450$ ps was used for all devices.

COUPLING OF THE DARK STATES TO THE RADIATIVE TRANSITION

The model employed throughout this paper has the dark states coupled to the ground state G of the radiative transition (Fig. 1(b) in the main text). One might instead envision scenarios in which the dark states are coupled to other states within the radiative transition. We find that the fits are relatively insensitive to which specific state within the radiative transition they are coupled to. Physically, this is because the rates coupling the states

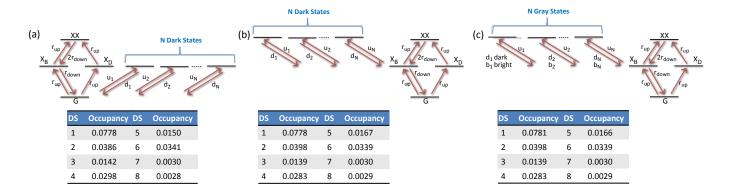


FIG. S5. Level diagrams (top) and extracted occupancies from fits (bottom) for a model with (a) dark states coupled to the ground state G; (b) dark states coupled to the excited state X_B ; (c) partially emissive 'gray' states emitting photons in the allowed spectral window 50 % of the time ($\alpha = 1$).

G, X_B, X_D, and XX are more than an order of magnitude faster than rates to the dark states.

As an example, we compare the dark state occupancies determined based on fits to the model presented in the main text (and re-displayed in Fig. S5(a)) with occupancies based on fits to a model in which the dark states are coupled to state X_B (Fig. S5(b)). Optimizing the fits based on the χ^2 parameter, we find that the individual dark state occupancies and the total occupancy of the dark states (and hence, the radiative efficiency of the quantum dot) are only slightly different in the two cases.

We also considered the possibility of partially emissive 'gray' states instead of dark states [11]. In this model, dark state i decays radiatively with rate b_i (into the same spectral channel as the QD excitonic transition) and non-radiatively with rate d_i , as shown schematically in Fig. S5(c). We set the radiative fraction of each dark state to be equal, so $b_i = \alpha d_i$. Even with a radiative fraction as large as $\alpha = 1$, the quality of the fit and the occupancies of each dark (shown in Fig. S5(c)) are nearly identical to the case with non-emitting dark states, again a consequence of the vast difference in the rates that couple the excitonic transition relative to the rates that couple to the dark states.

LABELING OF DARK STATES

In the main text, we have labeled dark states in the $g^{(2)}(\tau)$ data according to times $\tau_i = 1/(u_i + d_i)$, under the assumption that these times correspond to points of maximal slope. This assignment is expected to be only approximate, since it essentially assumes that the different dark states have no influence on each other. We compare the τ_i labeled in the above manner with the exact values at which $g^{(2)}(\tau)$ shows maximal slope in Fig. S6, and the expected approximate correspondence is observed. In addition, for each dark state we also show

the ratio $-u_i/d_i$, which is directly related to the occupancy of that state. This provides a graphical representation of which dark states most influence the radiative efficiency of the quantum dot.

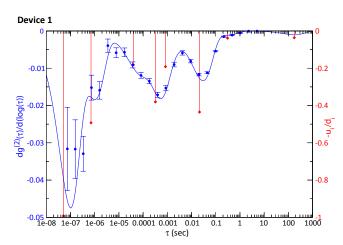


FIG. S6. Logarithmic derivative of $g^{(2)}(t)$, $\frac{d(g^{(2)}(\tau))}{d(\log(\tau))}$, for Device 1. Blue points are from the measured data, while the solid blue curve is from the rate equation model fit. The red points indicate the times $\tau_i = 1/(u_i + d_i)$, with the y-axis values given by $-u_i/d_i$, which is directly related to the occupancy of the dark state.

TUNNELING TO TRAPS

Recent studies have suggested that deep traps form close to InAs/GaAs QDs during growth [12, 13]. For example, Asano and colleagues have studied trap densities in different regions of QD-containing material and have found their density to increase in the presence of the QDs [13]. Tunneling of carriers to these traps could cause the observed blinking.

As a plausibility check, we consider the work of Schroeter *et al.*, who computed the tunneling of electrons in a spherical 5 nm radius In_{0.5}Ga_{0.5}As dot to a trap in the GaAs matrix, finding transition rates that vary enormously as the separation between the QD and trap is changed from 10 nm to 20 nm (see Fig. 3 in Ref. 14).

Using the parameters in Ref. 14, the energy level of the trap, which is modeled as a delta function potential, lies between the ground and first excited levels of the QD. We computed the electron transition rates from the first excited state of the QD (labeled C1) to the trap (labeled T), and from the trap to the ground state of the QD (labeled C0. The results as a function of the separation between the QD and the trap are shown in Fig. S7. The $C1 \rightarrow T$ transition rate varies from 10^{14} s⁻¹ to 10^{11} s⁻¹ for dot-trap separations of 5 nm to 20 nm, while the $T \rightarrow C0$ rate varies from over 10^{12} s⁻¹ to less than 10^5 s⁻¹. The strong variation in tunneling rates over this distance range is consistent with the wide range of transition rates produced in the rate equation model fits to the $g^{(2)}(\tau)$ data from the main text.

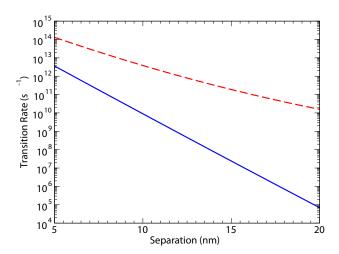


FIG. S7. Calculated transition rates between an $In_{0.5}Ga_{0.5}As/GaAs$ QD and a nearby trap, as a function of QD-trap separation, following Ref. 14. The QD excited state (C1) to trap (T) rate is shown as a red dashed line, while the trap to QD ground state (C0) rate is shown as a blue solid line.

Stark shifts of the QD energy levels, created when carriers populate nearby traps, could be another physical mechanism involved. One resulting phenomenon would be spectral diffusion, that is, a fluctuation in the QD emission frequency. For such spectral diffusion to result in an intensity fluctuation (blinking), its magnitude would need to be on the order of the optical filter bandwidth we use $(250~\mu\text{eV})$ when spectrally isolating the QD emission. Recently, Houel and colleauges [15] have experimentally and theoretically studied spectral diffusion in InAs/GaAs QDs, and predict a Stark shift of

 $\approx 20 \mu \text{eV}$ when a single carrier (hole) is situated within a couple of nm of the QD. Presumably multiple defect states would need to be simultaneously filled to reach shifts large enough to move the QD emission frequency outside of our filter window. In such a scenario, a wide range of timescales for spectral diffusion could lead to the observed results. For example, Abbarchi et al. have recently studied spectral diffusion in GaAs QDs through a correlation function approach, and fit their data to a function whose long-time scale behavior (i.e., at times much greater than the QD radiative lifetime) is given by a standard diffusion expression, meant to represent the displacement of a charge carrier near the QD [16]. Plotted on a logarithmic time scale, this function shows a shoulder reminiscent of those seen in Figs. 2-4 in the main text. One could then envision a model consisting of multiple charge carriers, each causing Stark shifts to the QD emission energy and exhibiting diffusive motion with a different characteristic timescale, as producing qualitatively similar curves as the data we have measured in Figs. 2-4 in the main text. On the other hand, the precise time-dependent behavior of the diffusive motion does not agree with our data (diffusive motion has wider tails), and the requirement of multiple diffusive timescales disagrees with the observation made in Ref. 16, where a single diffusion time constant was used to model data from multiple quantum dots, and from this it was inferred that the behavior of the carrier diffusion was independent of the specific local environment.

Finally, we note that strong perturbation of the electron and hole wavefunctions due to the nearby charges has also been considered as a mechanism for blinking, by Sugisaki and colleagues [17], and if incorporated alongside a model for trap filling dynamics, might provide an alternative explanation for what we have observed.

BLINKING PROBABILITY DISTRIBUTIONS

As pointed out in [18], correlation functions can reveal the kinetics of the blinking signal over a large time range, however, they only provide averaged information about the distributions of bright and dark time intervals. Alternatively, probability distributions for the instantaneous intensity fluctuations can in principle be obtained from photon-counting histograms, providing complementary information for the characterization of single emitters. This technique is commonly done in the blinking literature [18–20], and has been applied towards epitaxiallygrown quantum dots [17, 21, 22]. In the latter case, exponential blinking time distributions have been reported, which suggests coupling of the quantum dots to neighboring two-level systems [23]. Such behavior contrasts with that of nanocrystal quantum dots, which are known to display power-law type distributions [20].

In what follows, we attempt to extract the probabil-

ity distributions of blinking intervals for a single quantum dot in one of our fabricated devices. The results of Ref. [20] suggest that reliable recovery of blinking probability distribution functions require that intensity histograms display clear bimodal distributions, with two non-overlapping peaks corresponding to dark and bright emitter states, and time trajectories with several thousands of blinking events; these criteria must furthermore be met for bin sizes Δt varying over at least a decade. Only one of our measured devices (Device 1) produced histograms with clear bimodal distributions, as shown in Fig. S8(a)-(c), for bin widths Δt varying over almost a decade (from 5 ms up to 40 ms).

Although it is clear that there is some overlap between the bright and dark histogram peaks, we proceed to analyze the probability distributions of the 'on' and 'off' time intervals of this device. We start by defining an emission rate threshold for the binned data, below which the dot was considered to be in a dark or 'off' state, and, above it, in a bright or 'on' state it. Histograms of the durations of 'off' and 'on' state intervals were produced, and fitted on a log scale to a linear polynomial using a least-squares routine. Before fitting, the statistical weighting scheme of refs. [20, 24] was applied to the raw data, which

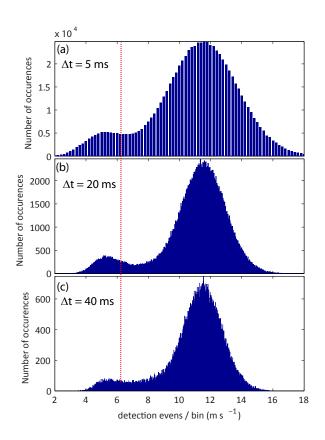


FIG. S8. Histograms of single-photon detection events per bin, for bin sizes Δt of (a) 5 ms, (b) 20 ms and (c) 40 ms. The red dashed line indicates the threshold level used to produce the probability distributions shown in Fig. S9(a).

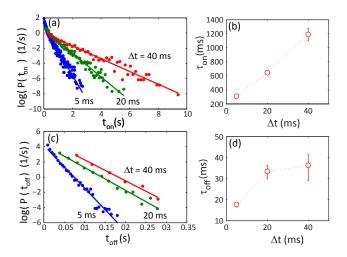


FIG. S9. (a) Exponential fits (in log-linear scale) to weighted on-state time interval distributions, obtained for bin widths $\Delta t = 5$ ms, 20 ms and 40 ms, and intensity threshold $I_{th} = 0.8I_{th,eq}$, with $I_{th,eq}$ as in eq. (S6). (b) Extracted characteristic times for on-states t_{on} . Error bars are 95 % confidence intervals. (c) and (d) are the same for 'off'-times.

produced the following probability distributions:

$$P(t_{off/on}) = \frac{N(t_{off/on})}{N^{tot}(t_{off/on})} \frac{1}{\delta t_{avg,on/off}}.$$
 (S5)

Here, $N(t_{off/on})$ is the number of 'off' or 'on' events of duration $t_{off/on}$, $N^{tot}(t_{off/on})$ is the total number of events in the time series, and $\delta t_{avg,on/off}$ is the average time interval between next neighbor events. This weighting is done to provide better statistical estimates for the probability distributions at long times, where the data is noisy and very sparse due to the finite duration of the measurement. Figures S9(a) and (b) respectively show 'on' and 'off' state time interval distributions for $\Delta t = 5$ ms, 20 ms and 40 ms, for an intensity threshold $I = 0.8 \times I_{th,eq}$ indicated by a red dashed line in Figs. S8(a)-(c). Here, $I_{th,eq}$ is equidistant, in standard deviations, from the 'on' and 'off' intensities $I_{off/on}$ [18]:

$$\frac{I_{th,eq} - I_{off}}{\sqrt{I_{off}}} = \frac{I_{th,eq} - I_{on}}{\sqrt{I_{on}}},$$
 (S6)

The closeness of the fits to the experimental data suggest that the 'on' and 'off' time probability distributions are single exponential, however it is evident that the characteristic times differ by a significant amount for different Δt values. To understand how much data processing influences the results, Figs. S10(a) and (b) show the range of characteristic times (τ_{on} and τ_{off}) obtained, as a function of I_{th} , for bin widths Δt between 5 ms and 40 ms. The thick lines in the figures correspond to averages over all Δt , at each I_{th} . The mean characteristic time for the 'on' state is seen to vary widely, from close to 1330 ms

for I_{th} at the low intensity peak, to near 100 ms for I_{th} at the high intensity peak, and a similar behavior is observed for the 'off' times. Primarily, this large variation has to do with the quality of the fits, which we evaluate through the 95 % confidence intervals. For the single exponential functions $\exp(a_{on/off} \cdot t_{on/off} + b_{on/off})$, we plot, in Figs. S10(c), the figure of merit

$$R_{on/off} = \sqrt{\left(\frac{\delta a_{on/off}}{a_{on/off}}\right)^2 + \left(\frac{\delta b_{on/off}}{b_{on/off}}\right)^2}, \quad (S7)$$

averaged over all bin widths Δt .

In eq.(S7), $\delta a_{on/off}$ and $\delta b_{on/off}$ are the 95 % fit confidence intervals. Evidently, the overall fit quality for 'on' and 'off' times decreases significantly as I_{th} approaches I_{on} and I_{off} respectively, and reaches a baseline as I_{th} moves towards the opposite extremes. Due to the overlap between the bright and dark peaks in the histograms of Figs. S8(a)-(c), 'on' and 'off' times are related through I_{th} , and so we may establish that reliable characteristic times can be found only within I_{th} intervals for which $\langle R_{on/off} \rangle$ are simultaneously minimized. Within the interval 7 ms⁻1 $\langle I_{th}/\Delta t \rangle$ ms⁻¹, τ_{off} ranges between 25 ms and 50 ms, and τ_{on} between 100 ms and 850 ms.

In summary, our analysis of the blinking trajectories shows that, within valid threshold and bin size ranges, 'on' and 'off' time distributions can be reasonably well-fit to single exponentials, as observed in other self-assembled quantum dots; it is clear that the probability distributions do not follow power laws as is the case for colloidal dots. On the other hand, the uncertainties for the characteristic times are very wide, as extracted values vary significantly with the choice of intensity threshold. This limitation is strongly related to the poor resolution of the 'on' and 'off' peaks, which is indeed maximized over only a small range - at most a decade - of bin widths. An additional issue for the 'off' times distribution is that the bin sizes over which peak resolution is clear are comparable to the 'off' time characteristic times, while, ideally, $\tau_{off}/\Delta t < 10$ for good resolution of blinking events. As noted in [20], it is apparent that blinking trajectory analysis requires a very stringent set of conditions for the data, so that reliable information may be extracted regarding the on/off time distributions. This contrasts with the correlation analysis performed in the main text, which is known to produce reliable quantitative information when directly applied to raw data [18] - albeit not directly providing information about the blinking interval distributions.

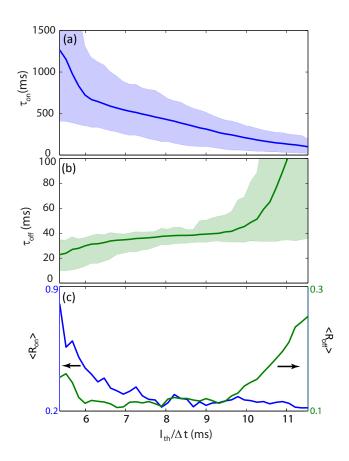


FIG. S10. (a) and (b): Extracted characteristic times for 'on'- (τ_{on}) and 'off'- (τ_{off}) time distributions, as functions of the threshold intensity I_{th} . Shaded areas show the spread of possible characteristic times extracted from data binned with Δt varying between 5 ms and 40 ms. Thick lines are averages over time bins.(c). Linear fit figure of merit $R_{om/off}$ (eq. (S7)) (averaged over all Δt) as a function of I_{th} .

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